Sampling methods for low-frequency electromagnetic imaging

Bastian Gebauer

gebauer@math.uni-mainz.de

Institut für Mathematik, Joh. Gutenberg-Universität Mainz, Germany

Joint work with Jin Keun Seo, Yonsei University, Seoul, Korea

IS08 - SIAM Conference on Imaging Science

San Diego, CA, USA, July 7 – 9, 2008



Low-frequency electromagnetics

Several physically relevant settings for LF-EM imaging.

- Charges/currents applied away from conducting medium
- → Inverse scattering problems
 - Electric charges ~> Electrostatics, Laplace-equation
 - Current loops ~> Magnetostatics, curl-curl-equation
 - Eddy current in conducting objects, parabolic-elliptic equations
- Currents applied directly to conducting medium
- → Electrical Impedance Tomography
 - **•** freq. $< 1 \mathrm{kHz} \iff$ static currents, real conductivity
 - $1 \text{kHz} < \text{freq.} < 100 \text{kHz} \implies$ phase shifts, complex conductivity

In this talk: EIT with complex conductivity.

Electrical impedance tomography





(Images taken from EIT group at Oxford Brookes University, published in Wikipedia by William Lionheart)

- Apply one or several input currents to a body and measure the resulting voltages
- Goal: Obtain an image of the interior conductivity distribution.
- Possible advantages:
 - EIT may be less harmful than other tomography techniques,
 - Conductivity contrast is high in many medical applications

Electrical impedance tomography

Idealized model for EIT:

- Apply all possible currents g on boundary of the body B
- \rightarrow Electric potential u that solves

$$\nabla \cdot \gamma^{\omega} \nabla u = 0, \qquad \gamma^{\omega} \partial_{\nu} u |_{\partial B} = g$$

($\gamma^{\omega} = \sigma + i\omega\epsilon$, σ real conductivity, ϵ dielectricity)

- Measure corresponding potential u everywhere on ∂B .
- \rightsquigarrow Current-to-voltage map Λ : $g \mapsto u|_{\partial B}$.

Direct Problem: (Standard theory for linear, elliptic PDEs):

- For $\sigma \in L^{\infty}_{+}(B)$, $\epsilon \in L^{\infty}(B)$, $g \in L^{2}_{\diamond}(\partial B) := \{\tilde{g} \in L^{2} : \int \tilde{g} = 0\}$ there exists a unique solution $u \in H^{1}_{\diamond}(B) := H^{1}(B)/\mathbb{C}$.
- Current-to-voltage map Λ : $L^2_{\diamond}(\partial B) \to L^2_{\diamond}(\partial B)$ is a compact, linear operator.

Detecting inclusions in EIT

Special case of EIT: locate inclusions in known background medium.



B

Current-to-voltage map with inclusion: $\Lambda_1: g \mapsto u_1|_{\partial B},$ where u_1 solves $\nabla \cdot \gamma^{\omega} \nabla u_1 = 0 \quad \gamma^{\omega} \partial_{\nu} u_1|_{\partial B} = g$ with $\gamma^{\omega} = \gamma_0^{\omega} + \gamma_{\Omega}^{\omega} \chi_{\Omega},$ $(\gamma_0^{\omega} \in \mathbb{C}:$ background conductivity). Current-to-voltage map without inclusion:

 $\Lambda_0: g \mapsto u_0|_{\partial B},$

where u_0 solves analogous equation with $\gamma^{\omega} = \gamma_0^{\omega}$.

"Reference measurements"

Goal: Locate Ω from comparing Λ_1 with Λ_0 .



Factorization Method

Factorization Method:

 $\Phi_z|_{\partial B}\in \mathcal{R}(|\Lambda_0-\Lambda_1|^{1/2}) \quad ext{ if and only if } \quad z\in \Omega$

where

$$\nabla_x \cdot \gamma_0^{\omega} \nabla_x \Phi_z(x) = d \cdot \nabla_x \delta_z(x), \qquad \gamma_0^{\omega} \partial_{\nu(x)} \Phi_z|_{\partial B} = 0$$

(electric potential of dipole in point *z* with arbitrary direction *d*). \rightsquigarrow Measurements Λ_1 , Λ_0 determine Ω .

Numerical implementation:

- Calculate regularized approximation of preimage $|\Lambda_0 \Lambda_1|^{-1/2} \Phi_z|_{\partial B}$
- Plot norm of this approximation as function of z. ("Indicator function")
 - Larger norm \rightsquigarrow preimage does not exist $\rightsquigarrow z \notin \Omega$.
 - Smaller norm \rightsquigarrow preimage exists $\rightsquigarrow z \in \Omega$.

History and known results

FM relies on characterization of Ω via $\mathcal{R}(|\Lambda_0 - \Lambda_1|^{1/2})$.

- originally developed by Kirsch, 1998 for inverse scattering problems,
- generalized to real conductivity EIT with inclusions "with sharp jumps" and connected complement (Brühl and Hanke, 1999),
- extended to electrode models (Hyvönen, Hakula, Pursiainen, Lechleiter),
- detects inclusions with complex conductivity in real conductivity background (*Kirsch*, 2005),
- detects inclusions "without sharp jumps" (G. and Hyvönen 2007), "fills up holes" in case of disconn. complements (G. and Hyvönen 2008).
 - Here: Variant of FM that detects inclusion in complex conductivity case and works without reference measurements.

Reference measurements

- Factorization method uses difference $\Lambda_1 \Lambda_0$ between
 - actual measurements Λ_1
 - reference measurements Λ_0 at an inclusion-free body
- Advantage: If reference measurements are available then systematic errors cancel out, e.g., forward modeling errors about the body geometry.
- Disadvantage: If reference measurements have to be simulated (or calculated analytically) then forward modeling errors have a large impact on the reconstructions.
- In medical application, reference measurements at an inclusion-free body are usually not available.

Example



mainz

Possible solution

Replace reference measurements by meas. at another frequency:

- Solution Assume that for all x outside the inclusion Ω

 $\gamma^{\omega}(x) = \gamma_{0}^{\omega} \in \mathbb{C} \quad \text{ and } \quad \gamma^{\tau}(x) = \gamma_{0}^{\tau} \in \mathbb{C}$

- Using $\gamma_0^{\omega} \Lambda_{\omega}$ and $\gamma_0^{\tau} \Lambda_{\tau}$ scales down conductivity outside Ω to 1.
- \rightarrow Difference $\gamma_0^{\omega} \Lambda_{\omega} \gamma_0^{\tau} \Lambda_{\tau}$ should have similar properties to $\Lambda_1 \Lambda_0$.

FM should also work with $\gamma_0^{\omega}\Lambda_{\omega} - \gamma_0^{\tau}\Lambda_{\tau}$ instead of $\Lambda_1 - \Lambda_0$.

For non-zero frequencies, $\gamma_0^{\omega} \Lambda_{\omega}$ is not self-adjoint, so we will have to use its real or imaginary part

$$\Im(A) := \frac{1}{2i}(A - A^*), \qquad \Re(A) := \frac{1}{2}(A + A^*)$$

for an operator $A: L^2_{\diamond}(S) \to L^2_{\diamond}(S)$.

fdEIT

Theorem (G, Seo 2008)

Let Ω have a connected complement,

 $\gamma^{\omega}(x) = \gamma_0^{\omega} + \gamma_{\Omega}^{\omega}(x)\chi_{\Omega}(x), \text{ and } \gamma^{\tau}(x) = \gamma_0^{\tau} + \gamma_{\Omega}^{\tau}(x)\chi_{\Omega}(x).$ If $\Im\left(\frac{\gamma_{\Omega}^{\omega}}{\gamma_{\Omega}^{\omega}}\right) \in L^{\infty}_{+}(\Omega)$ or $-\Im\left(\frac{\gamma_{\Omega}^{\omega}}{\gamma_{\Omega}^{\omega}}\right) \in L^{\infty}_{+}(\Omega)$, then $z \in \Omega$ if and only if $\Phi_z|_{\partial B} \in \mathcal{R}\left(\left|\Im\left(\sigma_0^{\omega}\Lambda_{\omega}\right)\right|^{1/2}\right)$, $z \in \Omega$ if and only if $\Phi_z|_{\partial B} \in \mathcal{R}\left(|\Re\left(\sigma_0^{\omega}\Lambda_{\omega} - \sigma_0^{\tau}\Lambda_{\tau}\right)|^{1/2}\right)$. $(\tau = 0 \text{ possible and same assertion also holds with interchanged } \omega \text{ and } \tau).$

FM can be used on single non-zero frequency data or on frequency-difference data.

Interpretation

 $z \in \Omega$ if and only if $\Phi_z|_{\partial B} \in \mathcal{R}\left(|\Im\left(\sigma_0^{\omega}\Lambda_{\omega}\right)|^{1/2}\right)$,

- Using $\Im(\ldots)$ compares Λ_{ω} to its own adjoint ("phase information").
- Inclusion can be found from measurements at a single non-zero frequency without any reference measurements.

$$z \in \Omega$$
 if and only if $\Phi_z|_{\partial B} \in \mathcal{R}\left(|\Re\left(\sigma_0^{\omega}\Lambda_{\omega} - \sigma_0^{\tau}\Lambda_{ au}
ight)|^{1/2}
ight).$

- \mathfrak{P} $\Re(\ldots)$ compares two different frequencies.
- Reference measurements can be replaced by measurements at a different frequency, e.g. by comparing static with non-zero frequency measurements.

 $\omega = 0$ ("static measurements"): freq. < 1khz

 $\omega > 0$, but still low frequency: 1khz < freq. < 500khz

Numerical example



(Conductivities: $\sigma = 0.3 - 0.2\chi_{\Omega}(x), \quad \sigma_{\omega}(x) = 0.3 + 0.1i - 0.2\chi_{\Omega}(x).$)

Numerical example



Reconstructions of an ellipse-shaped body that is wrongly assumed to be a circle.



Conclusions

Conclusions:

- Simulating reference data makes Factorization Method vulnerable to forward modeling errors.
- Using frequency-difference measurements instead strongly improves FMs robustness. Results are comparable to those with correct reference data.

Open problems:

- Scaling the conductivity by simple multiplication only works for constant background conductivity.
- Unsolved problems in the theory of FM: convergent threshold choice, definiteness properties.